

**DETAILS OF PURCHASE ORDERS COSTING MORE THAN RS. 10.00 LAKHS
CONCLUDED DURING THE FINANCIAL YEAR 2006-2007**

Specifications of Equipment	Purchase Order No & its Date			Name of Firm	Value of order (Rs. In Lakh)
Vickers Hardness Standardizing machine with a maximum force 1177.20 N	14-III/KK(119)04-PB	1	20-Apr-06	M/s LTF, Italy	100.31
Automatic Pressure Indicator	14-III/ND(136)05-PB	2	08-May-06	M/S DH Instruments, USA	17.23
Phase Noise Test Set for precise and accurate measurement of SSB Phase Noise.	14-VI/ASG (385) 05-PB	7	08-Jun-06	M/S Timing Solutions, USA	18.74
Optical Aerosol Spectrometer with Light scattering principle. Model No. 1108	14-II(2178)05-PB	15	20-Jul-06	M/S Grimm Aerosol Technik GmbH & Co., Germany	14.00
Vector Network Analyser (VNA)	14-VI/PS(357)05-PB	17	26-Jul-06	M/S Agilent Technologies Singapore Sales Pte. Ltd., Singapore	63.00
Four Stage Ultrapure Grade Water purification system	14-VII/BCC (2109) 06-PB	84	24-Aug-06	M/S Millipore (I) Pvt. Ltd., Bangalore	10.00
Benchtop (Mobile) Two Pressure Humidity Calibration Standard	14-III/HK(179)06-PB	25	31-Aug-06	M/S Hart Scientific LLC, USA	22.00
Low Temp. & High Temp. attachment for Vibration Sample Magnetometer.	14-VI/RK (394) 06-PB	26	04-Sep-06	M/S Lakeshore Cryotronics, USA	30.20
Illuminance Meter	14-III/HC (180) 06-PB	28	11-Sep-06	M/S LMT Lichtmesstechnik GmbH, Berlin, Germany	19.34
Current Voltage (I-V) Source Measuring Unit (SMU) with integrated capacitance-Voltage Measuring and Analysing system.	14-VII/RS (2105) 06-PB	32	21-Sep-06	M/S Heithley Instruments gmbH, Germany	25.00
RF Impedance Analyser. ALPHA-ATB	14-VII/TDS (2108)06-PB	34	28-Sep-06	M/S Novo Control Tech. GmbH & Co., Germany	32.00
4-grid optics with LaB6 filament. Er LEED 150 Auger Package.	14-VII/G (2106) 06-PB	37	28-Sep-06	M/S Specs GmbH Germany	22.50
P-IV Computers, Monitors, Scanners etc.	17(333)06-PB	169	16-Nov-06	M/S DGS&D New Delhi	25.75
Integrating Sphere and software & Polarising prism.	14-VII/SC (2107) 06-PB	52	16-Nov-06	M/s Edinburgh Instruments Ltd., UK	13.57

Single Mode PM optical fiber delivery system. FC/APC DA 000104 PM	14-VI/ASG (395) 06-PB	55	29-Nov-06	M/S Toptica Photonics Ag Germany	12.00
Ozone Analyzer. APOA- 370 Horiba Ultra Violet Absorption.	14-II(2200)06-PB/	56	11-Dec-06	M/S Entrol Systems Corporation New Delhi	10.00
Closed cycle Variable Temp. Cryogenic system, Computer system. CCS 100/202 Model	14-VI/SK(359)05-PB	58 210	11-Dec-06	M/S Janis Research Company USA	10.43
High Precision Multifunction Calibrator, Computer Printer. 5720 A-2330 Model	14-VI/SK(389) 05-PB	60 224	15-Dec-06	M/S Fluke Corporation USA	23.92
35 gm Silver plate	17(355) 06-PB	228	18-Dec-06	M/S MMTC Ltd. New Delhi	10.20
Gas Chromatographs- GC-I & GC-II. Model No.- 6890N.	14-VII/PS (2102) 06-PB	80 288	24-Jan-07	M/S Agilent Tech singapore (ales) Pte Lyd. Singapore	47.08
Optical components for Dynamic Light Scattering studies using NIBS configuration consisting of (Part No. ZEN 1600) Model Zetasizer Nanos.	14-VII/STL (2144) 06-PB	84	15-Feb-07	M/s Malvern Intsruments Ltd. UK	22.27
Server etc.	17(371)06-PB	311	20-Feb-07	M/S DGS&D, New Delhi	21.35
Electrochemical Interface. Solartron Make.	14-VII/PKS (2121) 06-PB	95	22-Feb-07	M/S C-Tech International Ltd. UK	13.00
Automatic Liquid Crystal Analyzer. A LCT2-2 U Model	14-VI/AM (399) 06-PB	103	13-Mar-07	M/S Instec Inc USA	13.85
Precision Standard Resistors of value of 1micro ohm, 10 m ohm, 100Tohm etc.	14-VI/SK (392) 06-PB	109 110	16-Mar-07	M/S IET Labs, USA M/S Ohm Labs, USA	21.97
Reflectometry sample stage with mounting parts + Cu Absorber for Cu and Mo radiation, 0.08 mm Cu foil.	14-VII/SKH (2163) 06-PB	115	20-Mar-07	M/S Bruker AXS GmbH Germany	21.00
Goeble Mirror 40 mm for Cu Radiation, Incident/Diffracted Beam.	14-VII/SKH (2132) 06-PB	116	20-Mar-07	M/S Bruker AXS GmbH Germany	15.74
Scanning Probe Microscope (SPM) with Electronic Controller & Software. Models - CAFM, SCM, Tuna 2 & SSRM.	14-II(2196)06-PB	123	20-Mar-07	M/S Veeco Asia Pte Ltd. Singapore	113.00
Setup for I-V and C-V measurements. 4200 SCS/F Model	14-VI/SK (427)06-PB	132	28-Mar-07	M/S Keithley Instruments Germany	25.88
Benchtop X-ray Diffraction System. 2005 H 303 Rigaku Miniflex-II Disktop.	14-II(2217) 06-PB	137	29-Mar-07	M/S Rigaku Corporation Japan	32.30

Shadow Band Spectroradiometer with data logger. MFR-7 Multi-Filter Rotating Shadow band Radiometer.	14-II(2206)06-PB	138	29-Mar-07	M/S Yankee environmental System Inc. USA	23.19
Ultra High Vacuum Scanning Microscopy System	14-VI/SMS (2165) 06-PB	139	30-Mar-07	M/S Omichrome Germany	131.00
Precision Positioners & Holders	14-III/HC (187) 06-PB	140 141 142	30-Mar-07	M/S Ekspla USA	10.40
Desktop Computers	17(391)06-PB	383	30-Mar-07	M/S DGS&D New Delhi	16.50